

<b>Notice of References Cited</b>	Application/Control No. 09/892,732		Applicant(s)/Patent Under Reexamination IWAYAMA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0184886	08-2006	Chung et al.	715/758
*	B	US-6,708,172	03-2004	Wong et al.	707/10
	C	US-			
	D	US-			
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	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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